

Application No.	Applicant(s)	
10/639,925	PREIKSAS ET AL.	
Examiner	Art Unit	
Toan M. Le	2863	

SEARCHED				
Class	Subclass	Date	Examiner	
702	107	2/3/2005	TL	
250	396R	2/2/2005	TL	
250	201.3	2/3/2005	TL	
359	383	2/3/2005	TL	
359	17	2/3/2005	TL	
382	255	2/3/2005	TL	
Above	Updated	10/6/2005	TL	
250	311	10/6/2005	TL	
Above	Updated	12/22/2006	TL	
Above	Updated	9/12/2007	TL	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
:			-	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Electron Microscope, Control, Index	2/3/2005	TL		
Electron Microscope, Macro	2/11/2005	TL		
Electron Microscope, Computer Control	2/11/2005	TL		
East- See Search History Printout	10/6/2005	TL		
702/107; 250/396R,201.3,311; 359/383,17; 382/255 (Electron Microscope Index Interpolate)	12/17/2006	TL		
702/107; 250/396R,201.3,311; 359/383,17; 382/255 (Electron Microscope Index Interpolate)	9/12/2007	TL		
East- See Search History Printout	9/13/2007	TL		